## Low-Voltage, Single and Dual Supply, Dual 4 to 1 Multiplexer Analog Switch with Latch

The Intersil ISL43841 device is a precision, bidirectional, analog switches configured as a a dual 4 channel multiplexer/ demultiplexer designed to operate from a single +2 V to +12 V supply or from $\mathrm{a} \pm 2 \mathrm{~V}$ to $\pm 6 \mathrm{~V}$ supply. The device has a latch bar pin to lock in the last switch address.

ON resistance of $39 \Omega$ with a $\pm 5 \mathrm{~V}$ supply and $125 \Omega$ with a +3.3 V supply. Each switch can handle rail to rail analog signals. The off-leakage current is only 0.1 nA at $+25^{\circ} \mathrm{C}$ or 2.5 nA at $+85^{\circ} \mathrm{C}$.

All digital inputs have 0.8 V to 2.4 V logic thresholds, ensuring TTL/CMOS logic compatibility when using a single 3.3 V or +5 V supply or dual $\pm 5 \mathrm{~V}$ supplies.

The ISL43841 is a dual 4 to 1 multiplexer device. Table 1 summarizes the performance of this part.
table 1. features at a glance

| CONFIGURATION | DUAL 4:1 MUX |
| :---: | :---: |
| $\pm 5 \mathrm{~V}$ R ${ }_{\text {ON }}$ | $39 \Omega$ |
| $\pm 5 \mathrm{~V}$ ton/toff | 32ns/18ns |
| 12V R ${ }_{\text {ON }}$ | $32 \Omega$ |
| 12 V ton/tofF | 23ns/15ns |
| 5 V RON | $65 \Omega$ |
| 5 V ton/toff | 38ns/19ns |
| $3.3 \mathrm{~V} \mathrm{R}_{\mathrm{ON}}$ | $125 \Omega$ |
| 3.3 V ton/tofF | 70ns/32ns |
| Package | 20 Ld 4x4 QFN |

## Related Literature

- Technical Brief TB363 "Guidelines for Handling and Processing Moisture Sensitive Surface Mount Devices (SMDs)"
- Application Note AN557 "Recommended Test Procedures for Analog Switches"
- Application Note AN520 "CMOS Analog Multiplexers and Switches; Specifications and Application Considerations."
- Application Note AN1034 "Analog Switch and Multiplexer Applications"


## Features

- Fully Specified at $3.3 \mathrm{~V}, 5 \mathrm{~V}, \pm 5 \mathrm{~V}$, and 12 V Supplies for $10 \%$ Tolerances
- ON Resistance ( $\mathrm{R}_{\mathrm{ON}}$ ) Max, $\mathrm{V}_{\mathrm{S}}= \pm 4.5 \mathrm{~V} . \ldots$. . . . . . . $50 \Omega$
- ON Resistance ( $\mathrm{R}_{\mathrm{ON}}$ ) Max, $\mathrm{V}_{\mathrm{S}}=+3 \mathrm{~V}$. . . . . . . . . . . $155 \Omega$
- RON Matching Between Channels, $\mathrm{V}_{\mathrm{S}}= \pm 5 \mathrm{~V} \ldots . . . .<2 \Omega$
- Low Charge Injection, $\mathrm{V}_{\mathrm{S}}= \pm 5 \mathrm{~V} \ldots . . . . .$. . . . 1 pC (Max)
- Single Supply Operation. . . . . . . . . . . . . . . . . . . + 2 CV to +12 V
- Dual Supply Operation . . . . . . . . . . . . . . . . . . . . . $\pm 2 \mathrm{~V}$ to $\pm 6 \mathrm{~V}$
- Fast Switching Action $\left(\mathrm{V}_{\mathrm{S}}=+5 \mathrm{~V}\right)$
- ton ............................ . . . . . . . . . . . . . . . 38ns
- IOFF . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 19ns
- Guaranteed Max Off-leakage. . . . . . . . . . . . . . . . . . . . 2.5nA
- Guaranteed Break-Before-Make
- TTL, CMOS Compatible
- Pb-free available


## Applications

- Communications Systems
- Radios
- Telecom Infrastructure
- ADSL, VDSL Modems
- Test Equipment
- Medical Ultrasound
- Magnetic Resonance Image
- CT and PET Scanners (MRI)
- ATE
- Electrocardiograph
- Audio and Video Signal Routing
- Various Circuits
- +3V/+5V DACs and ADCs
- Sample and Hold Circuits
- Operational Amplifier Gain Switching Networks
- High Frequency Analog Switching
- High Speed Multiplexing
- Integrator Reset Circuits


## Pinout



ISL43841 (QFN)
TOP VIEW


Truth Table (Note)

| ISL43841 |  |  |  |
| :---: | :---: | :---: | :---: |
| $\overline{\text { LATCH }}$ | ADD2 | ADD1 | SWITCH ON |
| 0 | X | X | Last Switch Selected |
| 1 | 0 | 0 | NO0 |
| 1 | 0 | 1 | NO1 |
| 1 | 1 | 0 | NO2 |
| 1 | 1 | 1 | NO3 |

NOTE: Applies to either A or B switch. Logic " 0 " $\leq 0.8 \mathrm{~V}$. Logic " 1 " $\geq 2.4 \mathrm{~V}$, with V+ between 2.7 V and 10 V . $\mathrm{X}=$ Don't Care.

Pin Descriptions

| PIN | FUNCTION |
| :---: | :--- |
| V+ | Positive Power Supply Input |
| V- | Negative Power Supply Input. Connect to GND for <br> Single Supply Configurations. |
| GND | Ground Connection |
| LATCH | Digital Control Input. Connect to + V for Normal <br> Operation. Connect to GND to latch the last switch state. |
| COM | Analog Switch Common Pin |
| NO | Analog Switch Normally Open Pin |
| NC | Analog Switch Normally Closed Pin |
| ADD | Address Input Pin |
| N.C. | No Internal Connection |

Ordering Information

| PART NO. <br> (BRAND) | TEMP. <br> RANGE ( $\left.{ }^{\circ} \mathbf{C}\right)$ | PACKAGE | PKG. <br> DWG. \# |
| :--- | :---: | :--- | :--- |
| ISL43841IR <br> (43841IR) | -40 to 85 | 20 Ld QFN | L20.4×4 |
| ISL43841IRZ <br> (43841IR) (See Note) | -40 to 85 | 20 Ld QFN <br> (Pb-free) | L20.4×4 |

*Add "-T" suffix to part number for tape and reel packaging.
NOTE: Intersil Pb -free products employ special Pb -free material sets; molding compounds/die attach materials and $100 \%$ matte tin plate termination finish, which is compatible with both SnPb and Pb -free soldering operations. Intersil Pb -free products are MSL classified at Pb -free peak reflow temperatures that meet or exceed the Pb -free requirements of IPC/JEDEC J Std-020B.

| Absolute Maximum Ratings |  |
| :---: | :---: |
| V+ to V- | -0.3 to15V |
| V + to GND | -0.3 to15V |
| V - to GND. | -15 to 0.3V |
| Input Voltages |  |
| LATCH, NO, ADD (Note 1) | -0.3 to ((V+) + 0.3V) |
| Output Voltages |  |
| COM (Note 1) | -0.3 to ((V+) + 0.3V) |
| Continuous Current (Any Terminal) | $\pm 30 \mathrm{~mA}$ |
| Peak Current NO, NC, or COM (Pulsed 1ms, 10\% Duty Cycle, Max) | $\pm 100 \mathrm{~m} /$ |

## Thermal Information

Thermal Resistance (Typical, Note 2) $\quad \theta_{\mathrm{JA}}\left({ }^{\circ} \mathrm{C} / \mathrm{W}\right)$ 20 Ld 4x4 QFN Package . . . . . . . . . . . . . . . . . . . . . 45
Maximum Junction Temperature (Plastic Package) . . . . . . . $150^{\circ} \mathrm{C}$ Maximum Storage Temperature Range ............. $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$ Maximum Lead Temperature (Soldering 10s) . . . . . . . . . . . . $300^{\circ} \mathrm{C}$ (Lead Tips Only)

## Operating Conditions

Temperature Range
ISL43841IR
$-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTES:

1. Signals on NO, COM, ADD, or $\overline{\text { LATCH }}$ exceeding $\mathrm{V}+$ or V - are clamped by internal diodes. Limit forward diode current to maximum current ratings.
2. $\theta_{\mathrm{JA}}$ is measured with the component mounted on a low effective thermal conductivity test board in free air. See Tech Brief TB379 for details.

Electrical Specifications: $\pm \mathbf{5 V}$ Supply Test Conditions: $\mathrm{V}_{\text {SUPPLY }}= \pm 4.5 \mathrm{~V}$ to $\pm 5.5 \mathrm{~V}, \mathrm{GND}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{INH}}=2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{INL}}=0.8 \mathrm{~V}$ (Note 3), Unless Otherwise Specified

| PARAMETER | TEST CONDITIONS | TEMP <br> ( ${ }^{\circ} \mathrm{C}$ ) | (NOTE 4) <br> MIN | TYP | (NOTE 4) <br> MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH CHARACTERISTICS |  |  |  |  |  |  |
| Analog Signal Range, $\mathrm{V}_{\text {ANALOG }}$ |  | Full | V- | - | V+ | V |
| ON Resistance, RON | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}= \pm 4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{COM}}=2 \mathrm{~mA}, \mathrm{~V}_{\mathrm{NO}}=3 \mathrm{~V}, \\ & \text { (See Figure 6) } \end{aligned}$ | 25 | - | 44 | 50 | $\Omega$ |
|  |  | Full | - | - | 80 | $\Omega$ |
| RON Matching Between Channels, $\Delta \mathrm{R}_{\mathrm{ON}}$ | $\mathrm{V}_{\mathrm{S}}= \pm 4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{COM}}=2 \mathrm{~mA}, \mathrm{~V}_{\mathrm{NO}}=3 \mathrm{~V},($ Note 5$)$ | 25 | - | 1.3 | 4 | $\Omega$ |
|  |  | Full | - | - | 6 | $\Omega$ |
| RON Flatness, $\mathrm{R}_{\mathrm{FLAT}}$ (ON) | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}= \pm 4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{COM}}=2 \mathrm{~mA}, \mathrm{~V}_{\mathrm{NO}}= \pm 3 \mathrm{~V}, 0 \mathrm{~V}, \\ & \text { (Note 6) } \end{aligned}$ | 25 | - | 7.5 | 9 | $\Omega$ |
|  |  | Full | - | - | 12 | $\Omega$ |
| NO or NC OFF Leakage Current, ${ }^{\mathrm{I}} \mathrm{NO}$ (OFF) or ${ }^{\mathrm{I}} \mathrm{NC}(\mathrm{OFF})$ | $\mathrm{V}_{\mathrm{S}}= \pm 5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}= \pm 4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=\mp 4.5 \mathrm{~V}$, (Note 7) | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |
| COM OFF Leakage Current, ICOM(OFF) | $\mathrm{V}_{\mathrm{S}}= \pm 5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}= \pm 4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=\overline{+4.5 \mathrm{~V}}$, (Note 7) | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |
| COM ON Leakage Current, ICOM(ON) | $\mathrm{V}_{\mathrm{S}}= \pm 5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=\mathrm{V}_{\mathrm{NO}}= \pm 4.5 \mathrm{~V}$, (Note 7) | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |
| DIGITAL INPUT CHARACTERISTICS |  |  |  |  |  |  |
| Input Voltage High, $\mathrm{V}_{\overline{\mathrm{LATCH}}}$, $V_{\text {ADDH }}$ |  | Full | 2.4 | - | - | V |
| Input Voltage Low, V $\overline{\text { LATCHL }}$, $V_{\text {ADDL }}$ |  | Full | - | - | 0.8 | V |
| Input Current, $\overline{\text { LATCHH }}, \overline{\text { LATCHL }}$, $\mathrm{I}_{\mathrm{ADDH}}, \mathrm{I}_{\mathrm{ADDL}}$ | $\mathrm{V}_{\mathrm{S}}= \pm 5.5 \mathrm{~V}, \mathrm{~V}_{\overline{\text { LATCH }}}, \mathrm{V}_{\text {ADD }}=0 \mathrm{~V}$ or $\mathrm{V}_{+}$ | Full | -0.5 | 0.03 | 0.5 | $\mu \mathrm{A}$ |
| DYNAMIC CHARACTERISTICS |  |  |  |  |  |  |
| Address Transition Time, thRANS | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}= \pm 4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}= \pm 3 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=300 \Omega, \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \\ & \mathrm{~V}_{\mathrm{IN}}=0 \text { to } 3,(\text { See Figure 1) } \end{aligned}$ | 25 | - | 43 | 60 | ns |
|  |  | Full | - | - | 70 | ns |
| Break-Before-Make Time, $\mathrm{t}_{\text {BBM }}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}= \pm 5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=3 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=300 \Omega, \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \\ & \mathrm{~V}_{\mathrm{IN}}=0 \text { to } 3 \mathrm{~V}, \text { (See Figure 3) } \end{aligned}$ | Full | 2 | 7 | - | ns |

Electrical Specifications: $\pm \mathbf{5 V}$ Supply Test Conditions: $\mathrm{V}_{\text {SUPPLY }}= \pm 4.5 \mathrm{~V}$ to $\pm 5.5 \mathrm{~V}, \mathrm{GND}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{INH}}=2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{INL}}=0.8 \mathrm{~V}$ (Note 3), Unless Otherwise Specified (Continued)

| PARAMETER | TEST CONDITIONS | $\begin{aligned} & \text { TEMP } \\ & \left({ }^{\circ} \mathrm{C}\right) \end{aligned}$ | (NOTE 4) MIN | TYP | (NOTE 4) <br> MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Latch Setup Time, ts | (See Figure 4) | 25 | 25 | - | - | ns |
|  |  | Full | 35 | - | - | ns |
| Latch Hold Time, $\mathrm{t}_{\mathrm{H}}$ | (See Figure 4) | 25 | 0 | - | - | ns |
|  |  | Full | 0 | - | - | ns |
| Latch Pulse Width, twPW | (See Figure 4) | 25 | 15 | - | - | ns |
|  |  | Full | 25 | - | - | ns |
| Charge Injection, Q | $\mathrm{C}_{\mathrm{L}}=1.0 \mathrm{nF}, \mathrm{V}_{\mathrm{G}}=0 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=0 \Omega$, (See Figure 2) | 25 | - | 0.3 | 1 | pC |
| NO/NC OFF Capacitance, CoFF | $f=1 \mathrm{MHz}, \mathrm{V}_{\mathrm{NO}}=\mathrm{V}_{\mathrm{COM}}=0 \mathrm{~V}$, (See Figure 8) | 25 | - | 3 | - | pF |
| COM OFF Capacitance, C OFF | $f=1 \mathrm{MHz}, \mathrm{V}_{\mathrm{NO}}=\mathrm{V}_{\mathrm{COM}}=0 \mathrm{~V}$, (See Figure 8) | 25 | - | 12 | - | pF |
| COM ON Capacitance, $\mathrm{C}_{\text {COM }}(\mathrm{ON})$ | $f=1 \mathrm{MHz}, \mathrm{V}_{\mathrm{NO}}=\mathrm{V}_{\mathrm{COM}}=0 \mathrm{~V}$, (See Figure 8) | 25 | - | 18 | - | pF |
| OFF Isolation | $\mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{f}=100 \mathrm{kHz}, \mathrm{~V}_{\mathrm{NO}}=1 \mathrm{~V}_{\mathrm{RMS}},$ <br> (See Figures 5 and 7) | 25 | - | 92 | - | dB |
| Crosstalk, (Note 8) |  | 25 | - | $\leq 110$ | - | dB |
| All Hostile Crosstalk, (Note 8) |  | 25 | - | -105 | - | dB |
| POWER SUPPLY CHARACTERISTICS |  |  |  |  |  |  |
| Power Supply Range |  | Full | $\pm 2$ | - | $\pm 6$ | V |
| Positive Supply Current, I+ | $\begin{aligned} & \mathrm{V}_{\mathrm{S}}= \pm 5.5 \mathrm{~V}, \mathrm{~V}_{\overline{\mathrm{LATCH}}}, \mathrm{~V}_{\mathrm{ADD}}=0 \mathrm{~V} \text { or } \mathrm{V}+\text {, } \\ & \text { Switch On or Off } \end{aligned}$ | 25 | -1 | 0.1 | 1 | $\mu \mathrm{A}$ |
|  |  | Full | -1 | - | 1 | $\mu \mathrm{A}$ |
| Negative Supply Current, I- |  | 25 | -1 | 0.1 | 1 | $\mu \mathrm{A}$ |
|  |  | Full | -1 | - | 1 | $\mu \mathrm{A}$ |

## NOTES:

3. $\mathrm{V}_{\mathrm{IN}}=$ logic voltage to configure the device in a given state.
4. The algebraic convention, whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
5. $\Delta \mathrm{R}_{\mathrm{ON}}=\mathrm{R}_{\mathrm{ON}}(\mathrm{MAX})-\mathrm{R}_{\mathrm{ON}}(\mathrm{MIN})$.
6. Flatness is defined as the difference between maximum and minimum value of on-resistance over the specified analog signal range.
7. Leakage parameter is $100 \%$ tested at high temp, and guaranteed by correlation at $25^{\circ} \mathrm{C}$.
8. Between any two switches.

Electrical Specifications +12 V Supply Test Conditions: $\mathrm{V}+=+10.8 \mathrm{~V}$ to $+13.2 \mathrm{~V}, \mathrm{GND}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{INH}}=4 \mathrm{~V}, \mathrm{~V}_{\mathrm{INL}}=0.8 \mathrm{~V}$ (Note 3), Unless Otherwise Specified

| PARAMETER | TEST CONDITIONS | $\begin{gathered} \text { TEMP } \\ \left({ }^{\circ} \mathrm{C}\right) \end{gathered}$ | (NOTE 4) MIN | TYP | (NOTE4) MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH CHARACTERISTICS |  |  |  |  |  |  |
| Analog Signal Range, $\mathrm{V}_{\text {ANALOG }}$ |  | Full | 0 | - | V+ | V |
| ON Resistance, R ON | $\mathrm{V}+=10.8 \mathrm{~V}, \mathrm{I} \mathrm{COM}=1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{NO}}=9 \mathrm{~V}$, (See Figure 6) | 25 | - | 37 | 45 | $\Omega$ |
|  |  | Full | - |  | 55 | $\Omega$ |
| $\mathrm{R}_{\mathrm{ON}}$ Matching Between Channels, $\Delta \mathrm{R}_{\mathrm{ON}}$ | $\mathrm{V}+=10.8 \mathrm{~V}, \mathrm{I}_{\mathrm{COM}}=1.0 \mathrm{~mA}, \mathrm{~V}_{\text {NO }}=9 \mathrm{~V}$, (Note 5 ) | 25 | - | 1.2 | 2 | $\Omega$ |
|  |  | Full | - | - | 2 | $\Omega$ |
| RON Flatness, $\mathrm{R}_{\text {FLAT(ON }}$ ) | $\mathrm{V}+=10.8 \mathrm{~V}, \mathrm{I}_{\mathrm{COM}}=1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{NO}}=3 \mathrm{~V}, 6 \mathrm{~V}, 9 \mathrm{~V},($ (Note 6$)$ | 25 | - | 5 | 7 | $\Omega$ |
|  |  | Full | - | - | 7 | $\Omega$ |
| NO or NC OFF Leakage Current, $\mathrm{I}_{\mathrm{NO}(\mathrm{OFF})}$ or $\mathrm{I}_{\mathrm{NC}}(\mathrm{OFF})$ | $\mathrm{V}+=13.2 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=1 \mathrm{~V}, 12 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=12 \mathrm{~V}, 1 \mathrm{~V},($ (Note 7) | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |

## Electrical Specifications +12V Supply Test Conditions: $\mathrm{V}_{+}=+10.8 \mathrm{~V}$ to $+13.2 \mathrm{~V}, \mathrm{GND}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{INH}}=4 \mathrm{~V}, \mathrm{~V}_{\mathrm{INL}}=0.8 \mathrm{~V}$ (Note 3), Unless Otherwise Specified (Continued)

| PARAMETER | TEST CONDITIONS | $\begin{aligned} & \text { TEMP } \\ & \left({ }^{\circ} \mathrm{C}\right) \end{aligned}$ | (NOTE 4) MIN | TYP | (NOTE4) <br> MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| COM OFF Leakage Current, ICOM(OFF) | $\mathrm{V}+=13.2 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=12 \mathrm{~V}, 1 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=1 \mathrm{~V}, 12 \mathrm{~V},($ Note 7) | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |
| COM ON Leakage Current, ICOM(ON) | $\mathrm{V}+=13.2 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=1 \mathrm{~V}, 12 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=1 \mathrm{~V}, 12 \mathrm{~V} \text {, or }$ floating, (Note 7) | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |
| DIGITAL INPUT CHARACTERISTICS |  |  |  |  |  |  |
| Input Voltage High, $\mathrm{V}_{\mathrm{LATCH}}$, $V_{\text {ADDH }}$ |  | Full | 3.7 | 3.3 | - | V |
| Input Voltage Low, V$\overline{\text { LATCHL }}$, $V_{\text {ADDL }}$ |  | Full | - | 2.7 | 0.8 | V |
| Input Current, $\overline{\text { LATCHH, }}, \overline{\text { LATCHL }}$, $\mathrm{I}_{\mathrm{ADDH}}, \mathrm{I}_{\mathrm{ADDL}}$ | $\mathrm{V}_{+}=13.2 \mathrm{~V}, \mathrm{~V}_{\overline{\text { LATCH }}}, \mathrm{V}_{\text {ADD }}=0 \mathrm{~V}$ or $\mathrm{V}_{+}$ | Full | -0.5 | 0.03 | 0.5 | $\mu \mathrm{A}$ |
| DYNAMIC CHARACTERISTICS |  |  |  |  |  |  |
| Address Transition Time, t trans | $\begin{aligned} & \mathrm{V}_{+}=10.8 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=10 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=300 \Omega, \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \\ & \mathrm{~V}_{\mathrm{IN}}=0 \text { to } 4,(\text { See Figure 1) } \end{aligned}$ | 25 | - | 27 | 50 | ns |
|  |  | Full | - |  | 55 | ns |
| Break-Before-Make Time Delay, tb | $\begin{aligned} & \mathrm{V}_{+}=13.2 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=300 \Omega, \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \mathrm{~V}_{\mathrm{NO}}=10 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{IN}}=0 \text { to } 4 \text {, (See Figure } 3 \text { ) } \end{aligned}$ | Full | 2 | 5 | - | ns |
| Latch Setup Time, ts | (See Figure 4) | 25 | 25 | - | - | ns |
|  |  | Full | 35 | - | - | ns |
| Latch Hold Time, $\mathrm{t}_{\mathrm{H}}$ | (See Figure 4) | 25 | 0 | - | - | ns |
|  |  | Full | 0 | - | - | ns |
| Latch Pulse Width, twPW | (See Figure 4) | 25 | 15 | - | - | ns |
|  |  | Full | 25 | - | - | ns |
| Charge Injection, Q | $\mathrm{C}_{\mathrm{L}}=1.0 \mathrm{nF}, \mathrm{V}_{\mathrm{G}}=0 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=0 \Omega$, (See Figure 2) | 25 | - | 2.7 | 5 | pC |
| OFF Isolation | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{f}=100 \mathrm{kHz}, \mathrm{~V}_{\mathrm{NO}}=1 \mathrm{~V}_{\mathrm{RMS}}, \\ & \text { (See Figures } 5 \text { and } 7 \text { ) } \end{aligned}$ | 25 | - | 92 | - | dB |
| Crosstalk, (Note 8) |  | 25 | - | $\leq 110$ | - | dB |
| All Hostile Crosstalk, (Note 8) |  | 25 | - | -105 | - | dB |
| NO or NC OFF Capacitance, C CoFF | $\mathrm{f}=1 \mathrm{MHz}, \mathrm{V}_{\mathrm{NO}}=\mathrm{V}_{\text {COM }}=0 \mathrm{~V}$, (See Figure 8) | 25 | - | 3 | - | pF |
| COM OFF Capacitance, $\mathrm{C}_{\mathrm{COM}(\mathrm{OFF})}$ | $f=1 \mathrm{MHz}, \mathrm{V}_{\mathrm{NO}}=\mathrm{V}_{\mathrm{COM}}=0 \mathrm{~V}$, (See Figure 8) | 25 | - | 12 | - | pF |
| COM ON Capacitance, C COM(ON) | $f=1 \mathrm{MHz}, \mathrm{V}_{\mathrm{NO}}=\mathrm{V}_{\mathrm{COM}}=0 \mathrm{~V}$, (See Figure 8) | 25 | - | 18 | - | pF |
| POWER SUPPLY CHARACTERISTICS |  |  |  |  |  |  |
| Power Supply Range |  | Full | 2 | - | 12 | V |
| Positive Supply Current, I+ | $\begin{aligned} & \mathrm{V}_{+}=13.2 \mathrm{~V}, \mathrm{~V} \overline{\mathrm{LATCH}}, \mathrm{~V}_{\mathrm{ADD}}=0 \mathrm{~V} \text { or } \mathrm{V}_{+} \text {, } \\ & \text { all channels On or Off } \end{aligned}$ | Full | -1 | - | 1 | $\mu \mathrm{A}$ |
| Positive Supply Current, I- |  | Full | -1 | - | 1 | $\mu \mathrm{A}$ |

## Electrical Specifications: 5V Supply

Test Conditions: $\mathrm{V}+=+4.5 \mathrm{~V}$ to $+5.5 \mathrm{~V}, \mathrm{~V}-=\mathrm{GND}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{INH}}=2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{INL}}=0.8 \mathrm{~V}$ (Note 3), Unless Otherwise Specified

| PARAMETER | TEST CONDITIONS | $\begin{aligned} & \text { TEMP } \\ & \left({ }^{\circ} \mathrm{C}\right) \end{aligned}$ | $\begin{gathered} \text { MIN } \\ \text { (NOTE 4) } \end{gathered}$ | TYP | $\begin{gathered} \text { MAX } \\ \text { (NOTE 4) } \end{gathered}$ | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH CHARACTERISTICS |  |  |  |  |  |  |
| Analog Signal Range, $\mathrm{V}_{\text {ANALOG }}$ |  | Full | 0 | - | V+ | V |
| ON Resistance, R ${ }_{\text {ON }}$ | $\mathrm{V}+=4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{COM}}=1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{NO}}=3.5 \mathrm{~V}$, (See Figure 6) | 25 | - | 81 | 90 | $\Omega$ |
|  |  | Full | - | - | 120 | $\Omega$ |
| $\mathrm{R}_{\mathrm{ON}}$ Matching Between Channels, $\Delta \mathrm{R}_{\mathrm{ON}}$ | $\mathrm{V}+=4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{COM}}=1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{NO}}=3 \mathrm{~V},($ Note 5$)$ | 25 | - | 2.2 | 4 | $\Omega$ |
|  |  | Full | - | - | 6 | $\Omega$ |
| RON Flatness, $\mathrm{R}_{\mathrm{FLAT}}$ (ON) | $\mathrm{V}+=4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{COM}}=1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{NO}}=1 \mathrm{~V}, 2 \mathrm{~V}, 3 \mathrm{~V},($ Note 6$)$ | 25 | - | 11.5 | 17 | $\Omega$ |
|  |  | Full | - | - | 24 | $\Omega$ |
| NO or NC OFF Leakage Current, ${ }^{\prime} \mathrm{NO}$ (OFF) or ${ }^{\mathrm{I} N C(O F F)}$ | $\mathrm{V}_{+}=5.5 \mathrm{~V}, \mathrm{~V}_{\text {COM }}=1 \mathrm{~V}, 4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=4.5 \mathrm{~V}, 1 \mathrm{~V},($ (Note 7$)$ | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |
| COM OFF Leakage Current, ICOM(OFF) | $\mathrm{V}_{+}=5.5 \mathrm{~V}, \mathrm{~V}_{\text {COM }}=1 \mathrm{~V}, 4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=4.5 \mathrm{~V}, 1 \mathrm{~V},($ (Note 7$)$ | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |
| COM ON Leakage Current, ICOM(ON) | $\mathrm{V}_{+}=5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=\mathrm{V}_{\mathrm{NO}}=4.5 \mathrm{~V}$, (Note 7) | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |
| DIGITAL INPUT CHARACTERISTICS |  |  |  |  |  |  |
| Input Voltage High, $\mathrm{V}_{\overline{\mathrm{LATCH}}} \mathrm{H}$, $V_{\text {ADDH }}$ |  | Full | 2.4 | - | - | V |
| Input Voltage Low, $\mathrm{V}_{\overline{\mathrm{LATCH}}}$, $V_{\text {ADDL }}$ |  | Full | - | - | 0.8 | V |
| Input Current, $\overline{\text { LATCHH, }}, \overline{\text { LATCHL }}$, $\mathrm{I}_{\mathrm{ADDH}}, \mathrm{I}_{\mathrm{ADDL}}$ | $\mathrm{V}_{+}=5.5 \mathrm{~V}, \mathrm{~V}_{\overline{\text { LATCHH}}}, \mathrm{V}_{\text {ADD }}=0 \mathrm{~V}$ or $\mathrm{V}_{+}$ | Full | -0.5 | 0.03 | 0.5 | $\mu \mathrm{A}$ |
| DYNAMIC CHARACTERISTICS |  |  |  |  |  |  |
| Address Transition Time, ttrans | $\begin{aligned} & \mathrm{V}_{+}=4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=3 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=300 \Omega, \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \\ & \mathrm{~V}_{\mathrm{IN}}=0 \text { to } 3 \mathrm{~V} \text {, (See Figure 1) } \end{aligned}$ | 25 | - | 51 | 70 | ns |
|  |  | Full | - | - | 85 | ns |
| Break-Before-Make Time, ${ }_{\text {t }}$ (BBM | $\begin{aligned} & \mathrm{V}_{+}=5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=3 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=300 \Omega, \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \\ & \mathrm{~V}_{\mathrm{IN}}=0 \text { to } 3 \mathrm{~V} \text {, (See Figure 3) } \end{aligned}$ | Full | 2 | 9 | - | ns |
| Latch Setup Time, ts | (See Figure 4) | 25 | 25 | - | - | ns |
|  |  | Full | 35 | - | - | ns |
| Latch Hold Time, $\mathrm{t}_{\mathrm{H}}$ | (See Figure 4) | 25 | 0 | - | - | ns |
|  |  | Full | 0 | - | - | ns |
| Latch Pulse Width, twPW | (See Figure 4) | 25 | 15 | - | - | ns |
|  |  | Full | 25 | - | - | ns |
| Charge Injection, Q | $\mathrm{C}_{\mathrm{L}}=1.0 \mathrm{nF}, \mathrm{V}_{\mathrm{G}}=0 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=0 \Omega$, (See Figure 2) | 25 | - | 0.6 | 1.5 | pC |
| OFF Isolation | $\mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{f}=100 \mathrm{kHz}, \mathrm{~V}_{\mathrm{NO}}=1 \mathrm{~V}_{\mathrm{RMS}}$ <br> (See Figures 5 and 7) | 25 | - | 92 | - | dB |
| Crosstalk, (Note 8) |  | 25 | - | $\leq 110$ | - | dB |
| All Hostile Crosstalk, (Note 8) |  | 25 | - | -105 | - | dB |

## Electrical Specifications: 5V Supply

Test Conditions: $\mathrm{V}_{+}=+4.5 \mathrm{~V}$ to $+5.5 \mathrm{~V}, \mathrm{~V}-=\mathrm{GND}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{INH}}=2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{INL}}=0.8 \mathrm{~V}$ (Note 3 ), Unless Otherwise Specified (Continued)

| PARAMETER | TEST CONDITIONS | TEMP $\left({ }^{\circ} \mathrm{C}\right)$ | MIN (NOTE 4) | TYP | MAX <br> (NOTE 4) | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| POWER SUPPLY CHARACTERISTICS |  |  |  |  |  |  |
| Power Supply Range |  | Full | 2 | - | 12 | V |
| Positive Supply Current, I+ | $\mathrm{V}_{+}=5.5 \mathrm{~V}, \mathrm{~V}-=0 \mathrm{~V}, \mathrm{~V}_{\overline{\mathrm{LATCH}} \mathrm{H}}, \mathrm{~V}_{\mathrm{ADD}}=0 \mathrm{~V} \text { or } \mathrm{V}_{+},$ Switch On or Off | 25 | -1 | -0.1 | 1 | $\mu \mathrm{A}$ |
|  |  | Full | -1 | - | 1 | $\mu \mathrm{A}$ |
| Positive Supply Current, I- |  | 25 | -1 | -0.1 | 1 | $\mu \mathrm{A}$ |
|  |  | Full | -1 | - | 1 | $\mu \mathrm{A}$ |

Electrical Specifications: 3.3V Supply
Test Conditions: $\mathrm{V}_{+}=+3.0 \mathrm{~V}$ to $+3.6 \mathrm{~V}, \mathrm{~V}-=\mathrm{GND}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{INH}}=2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{INL}}=0.8 \mathrm{~V}$ (Note 3 ), Unless Otherwise Specified

| PARAMETER | TEST CONDITIONS | TEMP $\left({ }^{\circ} \mathrm{C}\right)$ | MIN (NOTE 4) | TYP | MAX <br> (NOTE 4) | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH CHARACTERISTICS |  |  |  |  |  |  |
| Analog Signal Range, V ${ }_{\text {ANALOG }}$ |  | Full | 0 | - | V+ | V |
| ON Resistance, $\mathrm{R}_{\mathrm{ON}}$ | $\mathrm{V}+=3.0 \mathrm{~V}, \mathrm{I}_{\mathrm{COM}}=1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{NO}}=1.5 \mathrm{~V}$, (See Figure 6) | 25 | - | 135 | 155 | $\Omega$ |
|  |  | Full | - | - | 200 | $\Omega$ |
| RON Matching Between Channels, $\Delta \mathrm{R}_{\mathrm{ON}}$ | $\mathrm{V}+=3.0 \mathrm{~V}, \mathrm{I}_{\mathrm{COM}}=1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{NO}}=1.5 \mathrm{~V},($ Note 5$)$ | 25 | - | 3.4 | 8 | $\Omega$ |
|  |  | Full | - | - | 10 | $\Omega$ |
| $\mathrm{R}_{\mathrm{ON}}$ Flatness, $\mathrm{R}_{\mathrm{FLAT}}(\mathrm{ON})$ | $\mathrm{V}+=3.0 \mathrm{~V}, \mathrm{I}_{\mathrm{COM}}=1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{NO}}=0.5 \mathrm{~V}, 1 \mathrm{~V}, 2 \mathrm{~V},($ Note 6) | 25 | - | 34 | 40 | $\Omega$ |
|  |  | Full | - | - | 50 | $\Omega$ |
| NO or NC OFF Leakage Current, $\mathrm{I}_{\mathrm{NO}(\mathrm{OFF})}$ or ${ }^{\mathrm{I}} \mathrm{NC}$ (OFF) | $\mathrm{V}+=3.6 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=0 \mathrm{~V}, 4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=3 \mathrm{~V}, 1 \mathrm{~V}$, (Note 7) | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |
| COM OFF Leakage Current, ICOM(OFF) | $\mathrm{V}+=3.6 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=0 \mathrm{~V}, 4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=3 \mathrm{~V}, 1 \mathrm{~V},($ Note 7) | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |
| COM ON Leakage Current, ICOM(ON) | $\mathrm{V}+=3.6 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=\mathrm{V}_{\mathrm{NO}}=3 \mathrm{~V},($ Note 7$)$ | 25 | -0.1 | 0.002 | 0.1 | nA |
|  |  | Full | -2.5 | - | 2.5 | nA |
| DIGITAL INPUT CHARACTERISTICS |  |  |  |  |  |  |
| Input Voltage High, V $\overline{\overline{L A T C H}}$, $V_{\text {ADDH }}$ |  | Full | 2.4 | - | - | V |
| Input Voltage Low, V $\overline{\text { LATCHL }}$, $V_{\text {ADDL }}$ |  | Full | - | - | 0.8 | V |
| Input Current, $\overline{\text { LATCHH}}, \overline{\text { LATCHL }}$, $\mathrm{I}_{\text {ADDH, }} \mathrm{I}_{\text {ADDL }}$ | $\mathrm{V}+=3.6 \mathrm{~V}, \mathrm{~V}_{\overline{\mathrm{LATCH}} \mathrm{H}}, \mathrm{V}_{\text {ADD }}=0 \mathrm{~V}$ or $\mathrm{V}_{+}$ | Full | -0.5 | 0.03 | 0.5 | $\mu \mathrm{A}$ |
| DYNAMIC CHARACTERISTICS |  |  |  |  |  |  |
| Address Transition Time, tTRANS | $\begin{aligned} & \mathrm{V}_{+}=3.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=1.5 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=300 \Omega, \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \\ & \mathrm{~V}_{\mathrm{IN}}=0 \text { to } 3 \mathrm{~V} \text {, (See Figure 1) } \end{aligned}$ | 25 | - | 96 | 120 | ns |
|  |  | Full | - | - | 145 | ns |
| Break-Before-Make Time, tBBM | $\begin{aligned} & \mathrm{V}_{+}=3.6 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}=1.5 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=300 \Omega, \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \\ & \mathrm{~V}_{\mathrm{IN}}=0 \text { to } 3 \mathrm{~V} \text {, (See Figure 3) } \end{aligned}$ | Full | 3 | 13 | - | ns |
| Latch Setup Time, ts | (See Figure 4) | 25 | 50 | - | - | ns |
|  |  | Full | 60 | - | - | ns |
| Latch Hold Time, $\mathrm{t}_{\mathrm{H}}$ | (See Figure 4) | 25 | 0 | - | - | ns |
|  |  | Full | 0 | - | - | ns |

Electrical Specifications: 3.3V Supply Test Conditions: $\mathrm{V}+=+3.0 \mathrm{~V}$ to $+3.6 \mathrm{~V}, \mathrm{~V}-=\mathrm{GND}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{INH}}=2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{INL}}=0.8 \mathrm{~V}$ (Note 3), Unless Otherwise Specified (Continued)

| PARAMETER | TEST CONDITIONS | $\begin{aligned} & \text { TEMP } \\ & \left({ }^{\circ} \mathrm{C}\right) \end{aligned}$ | $\begin{gathered} \text { MIN } \\ \text { (NOTE 4) } \end{gathered}$ | TYP | MAX <br> (NOTE 4) | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Latch Pulse Width, twPW | (See Figure 4) | 25 | 30 | - | - | ns |
|  |  | Full | 40 | - | - | ns |
| Charge Injection, Q | $\mathrm{C}_{\mathrm{L}}=1.0 \mathrm{nF}, \mathrm{V}_{\mathrm{G}}=0 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=0 \Omega$, (See Figure 2) | 25 | - | 0.3 | 1 | pC |
| OFF Isolation | $R_{L}=50 \Omega, C_{L}=15 \mathrm{pF}, \mathrm{f}=100 \mathrm{kHz}, \mathrm{~V}_{\mathrm{NO}}=1 \mathrm{~V}_{\mathrm{RMS}},$ <br> (See Figures 5 and 7) | 25 | - | 92 | - | dB |
| Crosstalk, (Note 8) |  | 25 | - | $\leq 110$ | - | dB |
| All Hostile Crosstalk, (Note 8) |  | 25 | - | -105 | - | dB |
| POWER SUPPLY CHARACTERISTICS |  |  |  |  |  |  |
| Power Supply Range |  | Full | 2 | - | 12 | V |
| Positive Supply Current, I+ | $\mathrm{V}_{+}=3.6 \mathrm{~V}, \mathrm{~V}-=0 \mathrm{~V}, \mathrm{~V}_{\text {LATCH }}, \mathrm{V}_{\mathrm{ADD}}=0 \mathrm{~V} \text { or } \mathrm{V}_{+} \text {, }$ Switch On or Off | 25 | -1 | 0.1 | 1 | $\mu \mathrm{A}$ |
|  |  | Full | -1 | - | 1 | $\mu \mathrm{A}$ |
| Positive Supply Current, I- |  | 25 | -1 | 0.1 | 1 | $\mu \mathrm{A}$ |
|  |  | Full | -1 | - | 1 | $\mu \mathrm{A}$ |

## Test Circuits and Waveforms



Logic input waveform is inverted for switches that have the opposite logic sense.


Repeat test for other switches. $C_{L}$ includes fixture and stray capacitance.

$$
\mathrm{V}_{\mathrm{OUT}}=\mathrm{V}_{(\mathrm{NO})} \frac{R_{\mathrm{L}}}{R_{\mathrm{L}}+R_{(\mathrm{ON})}}
$$

FIGURE 1B. ADDRESS ttrans TEST CIRCUIT

FIGURE 1. SWITCHING TIMES

## Test Circuits and Waveforms (Continued)



FIGURE 2A. Q MEASUREMENT POINTS


Repeat test for other switches.
FIGURE 2B. Q TEST CIRCUIT

FIGURE 2. CHARGE INJECTION


FIGURE 3A. $\mathrm{t}_{\mathrm{BBM}}$ MEASUREMENT POINTS


Repeat test for other switches. $\mathrm{C}_{\mathrm{L}}$ includes fixture and stray capacitance.

FIGURE 3B. $\mathrm{t}_{\mathrm{BBM}}$ TEST CIRCUIT

FIGURE 3. BREAK-BEFORE-MAKE TIME

$$
\mathrm{V}_{\mathrm{OUT}}=\mathrm{V}_{(\mathrm{NO})} \frac{R_{\mathrm{L}}}{R_{\mathrm{L}}+R_{(\mathrm{ON})}}
$$

FIGURE 4B. LATCH $\mathrm{t}_{\mathrm{S}}, \mathrm{t}_{\mathrm{H}}, \mathrm{t}_{\mathrm{MPW}}$ TEST CIRCUIT
FIGURE 4A. LATCH $\mathrm{t}_{\mathbf{S}}, \mathrm{t}_{\mathrm{H}}, \mathrm{t}_{\text {MPW }}$ MEASUREMENT POINTS


Repeat test for other switches. $C_{L}$ includes fixture and stray capacitance.
Logic input waveform is inverted for switches that have the opposite logic sense.

FIGURE 4. LATCH SETUP AND HOLD TIMES

## Test Circuits and Waveforms (Continued)



FIGURE 5. OFF ISOLATION TEST CIRCUIT


FIGURE 7. CROSSTALK TEST CIRCUIT

## Detailed Description

The ISL43841 analog switch offers a precise switching capability from a bipolar $\pm 2 \mathrm{~V}$ to $\pm 6 \mathrm{~V}$ or a single 2 V to 12 V supply with low on-resistance (39 ) and high speed operation (tON $=38 \mathrm{~ns}$, tOFF $=19 \mathrm{~ns}$ ) with dual 5 V supplies.

It has an latch bar pin to lock in the last switch address.
The device is especially well suited for applications using $\pm 5 \mathrm{~V}$ supplies. With $\pm 5 \mathrm{~V}$ supplies the performance (RON, Leakage, Charge Injection, ect.) is best in class.

High frequency applications also benefit from the wide bandwidth, and the very high off isolation and crosstalk rejection.


FIGURE 6. RON TEST CIRCUIT


FIGURE 8. CAPACITANCE TEST CIRCUIT

## Supply Sequencing And Overvoltage Protection

With any CMOS device, proper power supply sequencing is required to protect the device from excessive input currents which might permanently damage the IC. All I/O pins contain ESD protection diodes from the pin to $\mathrm{V}+$ and to $\mathrm{V}+$ (see Figure 9). To prevent forward biasing these diodes, $\mathrm{V}+$ and V- must be applied before any input signals, and input signal voltages must remain between $\mathrm{V}+$ and V -. If these conditions cannot be guaranteed, then one of the following two protection methods should be employed.

Logic inputs can easily be protected by adding a $1 \mathrm{k} \Omega$ resistor in series with the input (see Figure 9). The resistor limits the input current below the threshold that produces permanent damage, and the sub-microamp input current produces an insignificant voltage drop during normal operation.

This method is not applicable for the signal path inputs. Adding a series resistor to the switch input defeats the purpose of using a low R $\mathrm{R}_{\mathrm{ON}}$ switch, so two small signal diodes can be added in series with the supply pins to provide overvoltage protection for all pins (see Figure 9). These additional diodes limit the analog signal from 1 V below $\mathrm{V}+$ to 1 V above V -. The low leakage current performance is unaffected by this approach, but the switch resistance may increase, especially at low supply voltages.


FIGURE 9. INPUT OVERVOLTAGE PROTECTION

## Power-Supply Considerations

The ISL43841 construction is typical of most CMOS analog switches, in that they have three supply pins: $\mathrm{V}+$, V -, and GND. V+ and V-drive the internal CMOS switches and set their analog voltage limits, so there are no connections between the analog signal path and GND. Unlike switches with a 13 V maximum supply voltage, the ISL43841 15 V maximum supply voltage provides plenty of room for the $10 \%$ tolerance of 12 V supplies ( $\pm 6 \mathrm{~V}$ or 12 V single supply), as well as room for overshoot and noise spikes.
This switch device performs equally well when operated with bipolar or single voltage supplies. The minimum recommended supply voltage is 2 V or $\pm 2 \mathrm{~V}$. It is important to note that the input signal range, switching times, and onresistance degrade at lower supply voltages. Refer to the electrical specification tables and Typical Performance Curves for details.
V+ and GND power the internal logic (thus setting the digital switching point) and level shifters. The level shifters convert the logic levels to switched $V+$ and $V$ - signals to drive the analog switch gate terminals.

## Logic-Level Thresholds

V+ and GND power the internal logic stages, so V- has no affect on logic thresholds. This switch family is TTL compatible ( 0.8 V and 2.4 V ) over a $\mathrm{V}+$ supply range of 2.7 V to 10 V . At 12 V the $\mathrm{V}_{\mathrm{IH}}$ level is about 3.3 V . This is still below the CMOS guaranteed high output minimum level of 4 V , but noise margin is reduced. For best results with a 12 V supply, use a logic family that provides a $\mathrm{V}_{\mathrm{OH}}$ greater than 4 V .

The digital input stages draw supply current whenever the digital input voltage is not at one of the supply rails. Driving the digital input signals from GND to $\mathrm{V}+$ with a fast transition time minimizes power dissipation.

## High-Frequency Performance

In $50 \Omega$ systems, signal response is reasonably flat even past 100 MHz (see Figures 16 and 17). Figures 16 and 17 also illustrates that the frequency response is very consistent over varying analog signal levels.
An OFF switch acts like a capacitor and passes higher frequencies with less attenuation, resulting in signal feed through from a switch's input to its output. Off Isolation is the resistance to this feed through, while Crosstalk indicates the amount of feed through from one switch to another.
Figure 18 details the high Off Isolation and Crosstalk rejection provided by this family. At 10 MHz , Off Isolation is about 55 dB in $50 \Omega$ systems, decreasing approximately 20 dB per decade as frequency increases. Higher load impedances decrease Off Isolation and Crosstalk rejection due to the voltage divider action of the switch OFF impedance and the load impedance.

## Leakage Considerations

Reverse ESD protection diodes are internally connected between each analog-signal pin and both $\mathrm{V}+$ and V -. One of these diodes conducts if any analog signal exceeds $\mathrm{V}_{+}$ or V -.

Virtually all the analog leakage current comes from the ESD diodes to $\mathrm{V}+$ or V -. Although the ESD diodes on a given signal pin are identical and therefore fairly well balanced, they are reverse biased differently. Each is biased by either $\mathrm{V}+$ or V - and the analog signal. This means their leakages will vary as the signal varies. The difference in the two diode leakages to the $V+$ and $V$ - pins constitutes the analog-signalpath leakage current. All analog leakage current flows between each pin and one of the supply terminals, not to the other switch terminal. This is why both sides of a given switch can show leakage currents of the same or opposite polarity. There is no connection between the analog signal paths and GND.

Typical Performance Curves $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, Unless Otherwise Specified


FIGURE 10. ON RESISTANCE vs SUPPLY VOLTAGE


FIGURE 12. ON RESISTANCE vs SWITCH VOLTAGE


FIGURE 14. ADDRESS TRANS TIME vs SINGLE SUPPLY VOLTAGE


FIGURE 11. ON RESISTANCE vs SWITCH VOLTAGE


FIGURE 13. ON RESISTANCE vs SWITCH VOLTAGE


FIGURE 15. ADDRESS TRANS TIME vs DUAL SUPPLY VOLTAGE

Typical Performance Curves $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, Unless Otherwise Specified (Continued)


FIGURE 16. FREQUENCY RESPONSE


FIGURE 18. CROSSTALK AND OFF ISOLATION


FIGURE 17. FREQUENCY RESPONSE


FIGURE 19. CHARGE INJECTION vs SWITCH VOLTAGE

## Die Characteristics

SUBSTRATE POTENTIAL (POWERED UP):
GND
TRANSISTOR COUNT:
193
PROCESS:
Si Gate CMOS

## Quad Flat No-Lead Plastic Package (QFN) Micro Lead Frame Plastic Package (MLFP)



L20.4x4
20 LEAD QUAD FLAT NO-LEAD PLASTIC PACKAGE (COMPLIANT TO JEDEC MO-220VGGD-1 ISSUE C)

| SYMBOL | MILLIMETERS |  |  | NOTES |
| :---: | :---: | :---: | :---: | :---: |
|  | MIN | NOMINAL | MAX |  |
| A | 0.80 | 0.90 | 1.00 | - |
| A1 | - | - | 0.05 | - |
| A2 | - | - | 1.00 | 9 |
| A3 | 0.20 REF |  |  | 9 |
| b | 0.18 | 0.23 | 0.30 | 5, 8 |
| D | 4.00 BSC |  |  | - |
| D1 | 3.75 BSC |  |  | 9 |
| D2 | 1.95 | 2.10 | 2.25 | 7, 8 |
| E | 4.00 BSC |  |  | - |
| E1 | 3.75 BSC |  |  | 9 |
| E2 | 1.95 | 2.10 | 2.25 | 7, 8 |
| e | 0.50 BSC |  |  | - |
| k | 0.25 | - | - | - |
| L | 0.35 | 0.60 | 0.75 | 8 |
| L1 | - | - | 0.15 | 10 |
| N | 20 |  |  | 2 |
| Nd | 5 |  |  | 3 |
| Ne | 5 5 |  |  | 3 |
| P | - | - | 0.60 | 9 |
| $\theta$ | - | - | 12 | 9 |

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## NOTES:

1. Dimensioning and tolerancing conform to ASME Y14.5-1994.
2. $N$ is the number of terminals.
3. Nd and Ne refer to the number of terminals on each D and E .
4. All dimensions are in millimeters. Angles are in degrees.
5. Dimension $b$ applies to the metallized terminal and is measured between 0.15 mm and 0.30 mm from the terminal tip.
6. The configuration of the pin \#1 identifier is optional, but must be located within the zone indicated. The pin \#1 identifier may be either a mold or mark feature.
7. Dimensions D2 and E2 are for the exposed pads which provide improved electrical and thermal performance.
8. Nominal dimensions are provided to assist with PCB Land Pattern Design efforts, see Intersil Technical Brief TB389.
9. Features and dimensions A2, A3, D1, E1, P \& $\theta$ are present when Anvil singulation method is used and not present for saw singulation.
10. Depending on the method of lead termination at the edge of the package, a maximum 0.15 mm pull back (L1) maybe present. L minus L1 to be equal to or greater than 0.3 mm .

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Intersil Corporation's quality certifications can be viewed at www.intersil.com/design/quality

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